


<b>Search Notes</b>  	<b>Application/Control No.</b>  10568449	<b>Applicant(s)/Patent Under Reexamination</b>  AYEL ET AL.
	<b>Examiner</b>  JASON M MANDEVILLE	<b>Art Unit</b>  2629

SEARCHED			
Class	Subclass	Date	Examiner
345	38,55,97-100,87-95	08 October 2009	Jason Mandeville

SEARCH NOTES		
Search Notes	Date	Examiner
Searched US-PGPUB, USPAT, USOCR, FPRS, EPO, JPO, DERWENT, IBM_TDB	08 October 2009	Jason Mandeville
Inventor Search	08 October 2009	Jason Mandeville

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/J. M. M./  
Examiner,Art Unit 2629